AP9 Recid Pare Bockethy SEP 2003 Practice No. 3662

FORM HDP-1449 (Based on Form PTO-1449)

PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)

Sheet 1 of 2

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2691-000055/US New Application				
APPLICANT				
Takahiko YOSHIDA et al.				
FILING DATE	GROUP			
September 1, 2006	Unknown			

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH, /C.G./

Examiner: /Cassi Galt/ Date Considered: 09/03/2008

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Sheet 2 of 2

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	2691-000055/US	New Application			
	APPLICANT				
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Examiner:	/Cassi Galt/	Date Considered:	09/03/2008